



MOS FIELD EFFECT TRANSISTOR 2SK3456

SWITCHING N-CHANNEL POWER MOS FET

DESCRIPTION

The 2SK3456 is N-channel DMOS FET device that features a low gate charge and excellent switching characteristics, designed for high voltage applications such as switching power supply, AC adapter.

ORDERING INFORMATION

PART NUMBER	PACKAGE		
2SK3456	TO-220AB		
2SK3456-S	TO-262		
2SK3456-ZJ	TO-263		

FEATURES

- Low gate charge
- $Q_G = 30 \text{ nC TYP}$. (VDD = 400 V, VGS = 10 V, ID = 12 A)
- Gate voltage rating ± 30 V
- Low on-state resistance

 $R_{DS(on)} = 0.60 \ \Omega \ MAX. \ (V_{GS} = 10 \ V, \ I_D = 6.0 \ A)$

- Avalanche capability ratings
- Surface mount package available

ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

Drain to Source Voltage (Vgs = 0 V)	Vdss	500	V
Gate to Source Voltage (VDS = 0 V)	Vgss	±30	V
Drain Current (DC) (Tc = 25°C)	D(DC)	±12	А
Drain Current (Pulse) ^{Note1}	D(pulse)	±36	А
Total Power Dissipation ($T_A = 25^{\circ}C$)	P _{T1}	1.5	W
Total Power Dissipation (Tc = 25°C)	P _{T2}	100	W
Channel Temperature	Tch	150	°C
Storage Temperature	Tstg	–55 to +150	°C
Single Avalanche Current Note2	AS	12	А
Single Avalanche Energy Note2	Eas	103	mJ

Notes 1. PW \leq 10 μ s, Duty Cycle \leq 1%

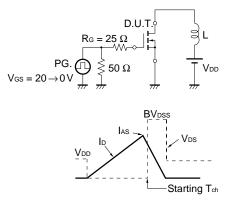
2. Starting T_{ch} = 25°C, V_{DD} = 150 V, R_G = 25 Ω , V_{GS} = 20 \rightarrow 0 V

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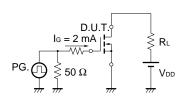
ELECTRICAL CHARACTERISTICS (TA = 25°C)

CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	loss	Vds = 500 V, Vgs = 0 V			100	μA
Gate Leakage Current	lgss	$V_{GS} = \pm 30 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$			±100	nA
Gate Cut-off Voltage	VGS(off)	V _{DS} = 10 V, I _D = 1 mA	2.5		3.5	V
Forward Transfer Admittance	y fs	Vds = 10 V, Id = 6.0 A	2.0			s
Drain to Source On-state Resistance	RDS(on)	Vgs = 10 V, Id = 6.0 A		0.48	0.60	Ω
Input Capacitance	Ciss	Vds = 10 V		1620		pF
Output Capacitance	Coss	Vgs = 0 V		250		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		10		pF
Turn-on Delay Time	td(on)	Vdd = 150 V, Id = 6.0 A		24		ns
Rise Time	tr	Vgs = 10 V		18		ns
Turn-off Delay Time	td(off)	R _G = 10 Ω		50		ns
Fall Time	tŕ			15		ns
Total Gate Charge	QG	Vdd = 400 V		30		nC
Gate to Source Charge	QGS	Vgs = 10 V		9		nC
Gate to Drain Charge	Qgd	ID = 12 A		11		nC
Body Diode Forward Voltage	VF(S-D)	IF = 12 A, VGS = 0 V		1.0		V
Reverse Recovery Time	trr	IF = 12 A, VGS = 0 V		1.5		μs
Reverse Recovery Charge	Qrr	di/dt = 50 A/ μs		11		μC

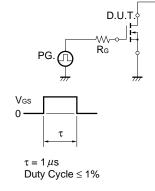
TEST CIRCUIT 1 AVALANCHE CAPABILITY

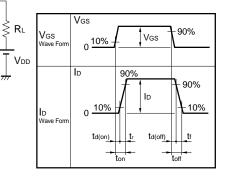


TEST CIRCUIT 3 GATE CHARGE



TEST CIRCUIT 2 SWITCHING TIME

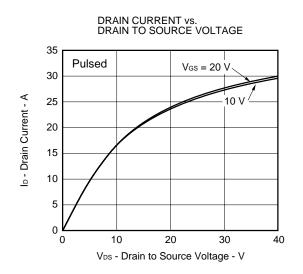




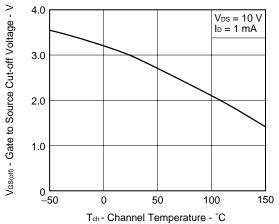
Data Sheet D14753EJ1V0DS

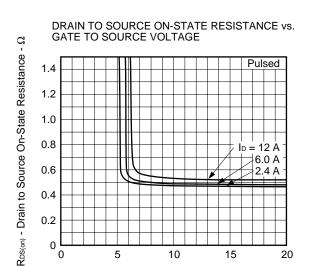
2

TYPICAL CHARACTERISTICS (TA = 25°C)



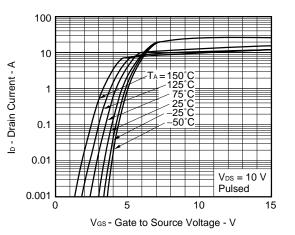




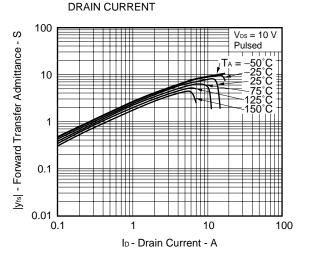


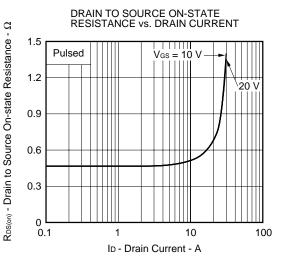
Vgs - Gate to Source Voltage - V

FORWARD TRANSFER CHARACTERISTICS

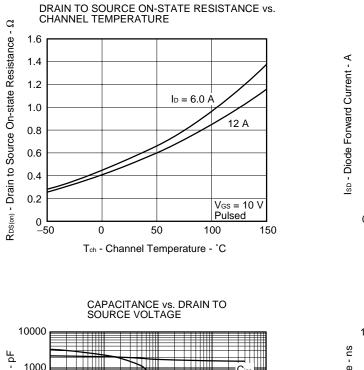


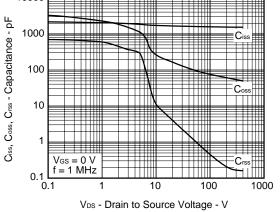
FORWARD TRANSFER ADMITTANCE vs.

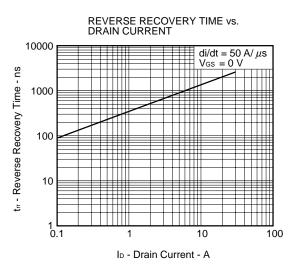


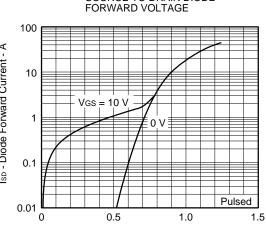


Data Sheet D14753EJ1V0DS





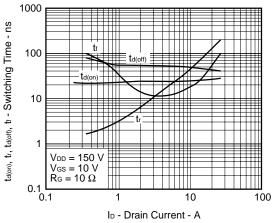




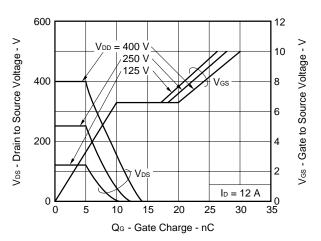
SOURCE TO DRAIN DIODE

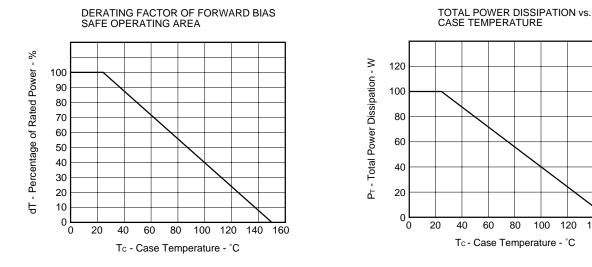
Vsp - Source to Drain Voltage - V

SWITCHING CHARACTERISTICS

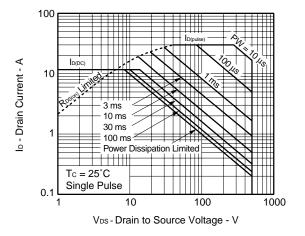


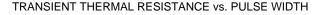
DYNAMIC INPUT/OUTPUT CHARACTERISTICS





FORWARD BIAS SAFE OPERATING AREA

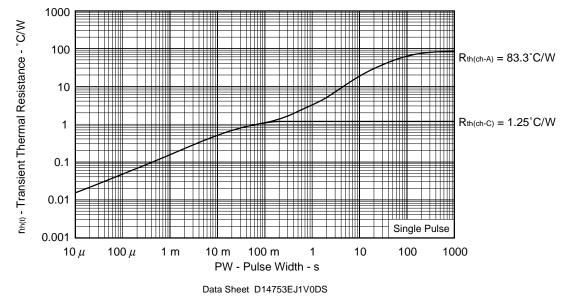


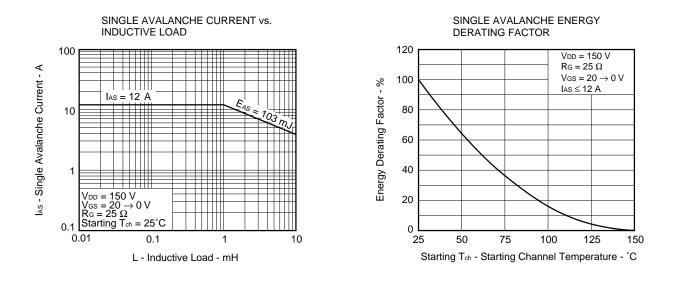


40 60 80 100 120

Tc - Case Temperature - °C

140 160





4.8 MAX.

0.5±0.2

1.Gate

2.Drain

3.Source

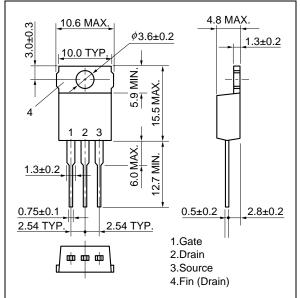
4.Fin (Drain)

1.3±0.2

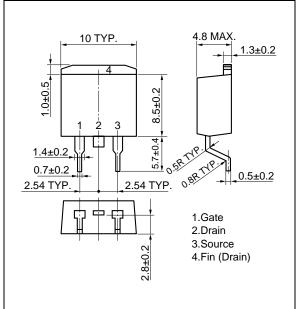
2.8±0.2

PACKAGE DRAWINGS (Unit: mm)

1) TO-220AB (MP-25)



3) TO-263 (MP-25ZJ)



EQUIVALENT CIRCUIT

2) TO-262 (MP-25 Fin Cut)

10 TYP

2 3

4

1.3±0.2

0.75±0.3 2.54 TYP ŝ

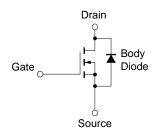
0±0.

8.5±0.

MM

2.7

2.54 TYP.



Remark Strong electric field, when exposed to this device, can cause destruction of the gate oxide and ultimately degrade the device operation. Steps must be taken to stop generation of static electricity as much as possible, and quickly dissipate it once, when it has occurred.

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